

Features

- High blocking voltage with low On-resistance
- High speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Qrr)
- Halogen free, RoHS compliant

Benefits

- Higher system efficiency
- Reduced cooling requirements
- Increased power density
- Increased system switching frequency

Applications

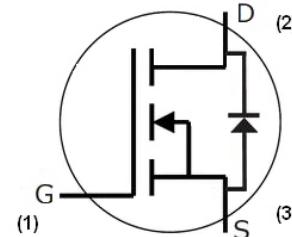
- Renewable energy
- High voltage DC/DC converters
- Switch Mode Power Supplies
- UPS

V_{DS}	1200 V
$I_D @ 25^\circ C$	17 A
$R_{DS(on)}$	160 mΩ



TO-247-3

Package



Maximum Ratings ($T_c = 25^\circ C$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
V_{DSmax}	Drain - Source Voltage	1200	V	$V_{GS} = 0 \text{ V}$, $I_D = 100 \mu\text{A}$	
V_{GSmax}	Gate - Source Voltage (dynamic)	-8/+19	V	AC ($f > 1 \text{ Hz}$)	Note: 1
V_{GSop}	Gate - Source Voltage (static)	-4/+15	V	Static	Note: 2
I_D	Continuous Drain Current	17	A	$V_{GS} = 15 \text{ V}$, $T_c = 25^\circ \text{C}$	Fig. 19
		12		$V_{GS} = 15 \text{ V}$, $T_c = 100^\circ \text{C}$	
$I_{D(pulse)}$	Pulsed Drain Current	34	A	Pulse width t_p limited by T_{jmax}	Fig. 22
P_D	Power Dissipation	97	W	$T_c = 25^\circ \text{C}$, $T_j = 150^\circ \text{C}$	Fig. 20
T_J, T_{stg}	Operating Junction and Storage Temperature	-55 to +150	°C		
T_L	Solder Temperature	260	°C	1.6mm (0.063") from case for 10s	
M_d	Mounting Torque	1 8.8	Nm lbf-in	M3 or 6-32 screw	

Note (1): When using MOSFET Body Diode $V_{GSmax} = -4\text{V}/+19\text{V}$

Note (2): MOSFET can also safely operate at 0/+15 V

Electrical Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note		
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	1200			V	$V_{GS} = 0 \text{ V}, I_D = 100 \mu\text{A}$			
$V_{GS(\text{th})}$	Gate Threshold Voltage	1.8	2.8	3.6	V	$V_{DS} = V_{GS}, I_D = 2.33 \text{ mA}$	Fig. 11		
			2.2		V	$V_{DS} = V_{GS}, I_D = 2.33 \text{ mA}, T_J = 150^\circ\text{C}$			
I_{DSS}	Zero Gate Voltage Drain Current		1	50	μA	$V_{DS} = 1200 \text{ V}, V_{GS} = 0 \text{ V}$			
I_{GSS}	Gate-Source Leakage Current		10	250	nA	$V_{GS} = 15 \text{ V}, V_{DS} = 0 \text{ V}$			
$R_{DS(\text{on})}$	Drain-Source On-State Resistance		160	208	$\text{m}\Omega$	$V_{GS} = 15 \text{ V}, I_D = 8.5 \text{ A}$	Fig. 4, 5, 6		
			256			$V_{GS} = 15 \text{ V}, I_D = 8.5 \text{ A}, T_J = 150^\circ\text{C}$			
g_{fs}	Transconductance		5.2		S	$V_{DS} = 20 \text{ V}, I_{DS} = 8.5 \text{ A}$	Fig. 7		
			4.9			$V_{DS} = 20 \text{ V}, I_{DS} = 8.5 \text{ A}, T_J = 150^\circ\text{C}$			
C_{iss}	Input Capacitance		632		pF	$V_{GS} = 0 \text{ V}, V_{DS} = 1000 \text{ V}$ $f = 1 \text{ MHz}$ $V_{AC} = 25 \text{ mV}$	Fig. 17, 18		
C_{oss}	Output Capacitance		39						
C_{rss}	Reverse Transfer Capacitance		3						
E_{oss}	C_{oss} Stored Energy		22.5		μJ	$V_{DS} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}, I_D = 8.5 \text{ A},$ $R_{G(\text{ext})} = 2.5 \Omega, L = 336 \mu\text{H}, T_J = 150^\circ\text{C}$	Fig. 16		
E_{ON}	Turn-On Switching Energy (SiC Diode FWD)		183		μJ				
E_{OFF}	Turn Off Switching Energy (SiC Diode FWD)		16		μJ				
E_{ON}	Turn-On Switching Energy (Body Diode FWD)		294		μJ				
E_{OFF}	Turn Off Switching Energy (Body Diode FWD)		14		μJ	$V_{DS} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}, I_D = 8.5 \text{ A},$ $R_{G(\text{ext})} = 2.5 \Omega, L = 336 \mu\text{H}, T_J = 150^\circ\text{C}$	Fig. 26, 29		
$t_{d(on)}$	Turn-On Delay Time		30		ns				
t_r	Rise Time		16						
$t_{d(off)}$	Turn-Off Delay Time		20						
t_f	Fall Time		13		$V_{DD} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$ $I_D = 8.5 \text{ A}, R_{G(\text{ext})} = 2.5 \Omega,$ Timing relative to V_{DS} Inductive load	Fig. 27, 28			
$R_{G(\text{int})}$	Internal Gate Resistance		8				Ω		
Q_{gs}	Gate to Source Charge		9			nC		Fig. 12	
Q_{gd}	Gate to Drain Charge		12						
Q_g	Total Gate Charge		38		Per IEC60747-8-4 pg 21				

Reverse Diode Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Diode Forward Voltage	4.5		V	$V_{GS} = -4 \text{ V}, I_{SD} = 3 \text{ A}$	Fig. 8, 9, 10
		4.0		V	$V_{GS} = -4 \text{ V}, I_{SD} = 3 \text{ A}, T_J = 150^\circ\text{C}$	
I_S	Continuous Diode Forward Current		17	A	$V_{GS} = -4 \text{ V}, T_J = 25^\circ\text{C}$	Note 1
$I_{S,pulse}$	Diode pulse Current		34	A	$V_{GS} = -4 \text{ V}, \text{pulse width } t_p \text{ limited by } T_{jmax}$	Note 1
t_{rr}	Reverse Recover time	34		ns	$V_{GS} = -4 \text{ V}, I_{SD} = 8.5 \text{ A}, V_R = 800 \text{ V}$ $dif/dt = 844 \text{ A}/\mu\text{s}, T_J = 150^\circ\text{C}$	Note 1
Q_{rr}	Reverse Recovery Charge	194		nC		
I_{rm}	Peak Reverse Recovery Current	8		A		

Thermal Characteristics

Symbol	Parameter	Typ.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	1.29	$^\circ\text{C}/\text{W}$		Fig. 21

Typical Performance

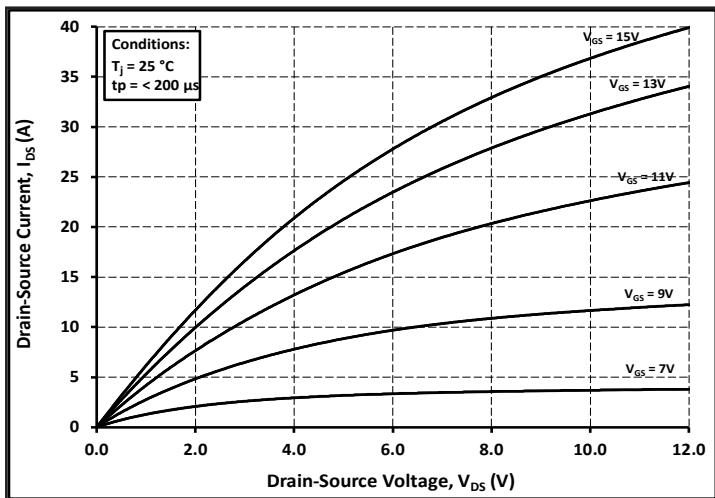
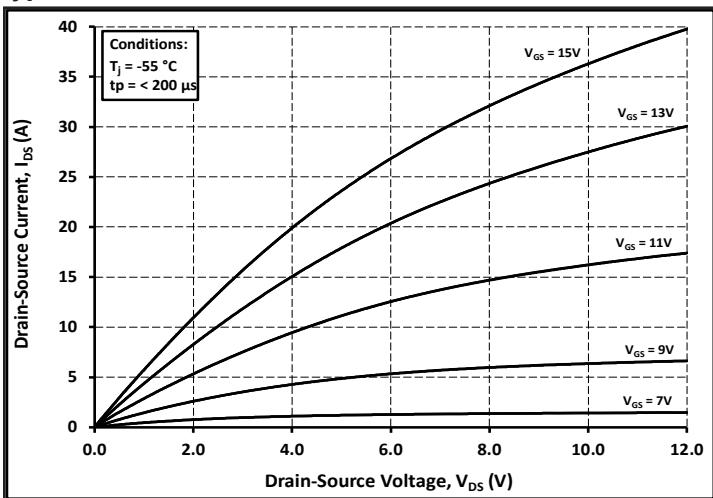


Figure 1. Output Characteristics $T_J = -55\text{ }^{\circ}\text{C}$

Figure 2. Output Characteristics $T_J = 25\text{ }^{\circ}\text{C}$

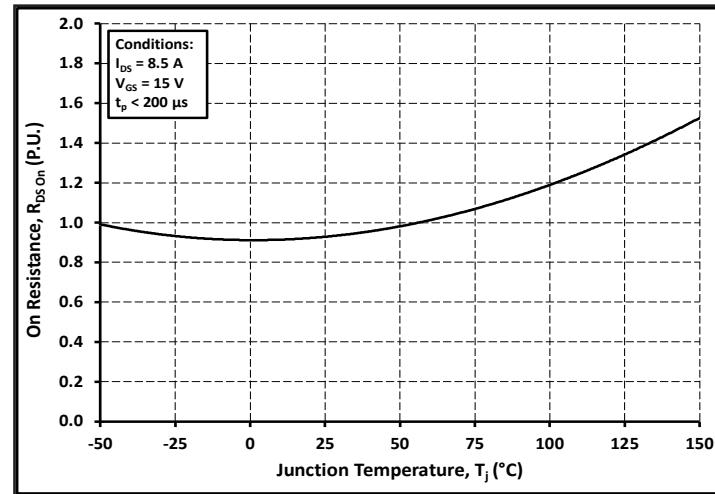
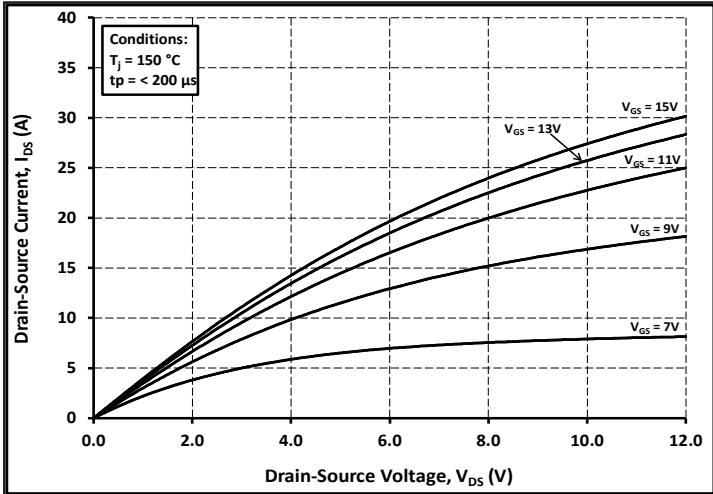


Figure 3. Output Characteristics $T_J = 150\text{ }^{\circ}\text{C}$

Figure 4. Normalized On-Resistance vs. Temperature

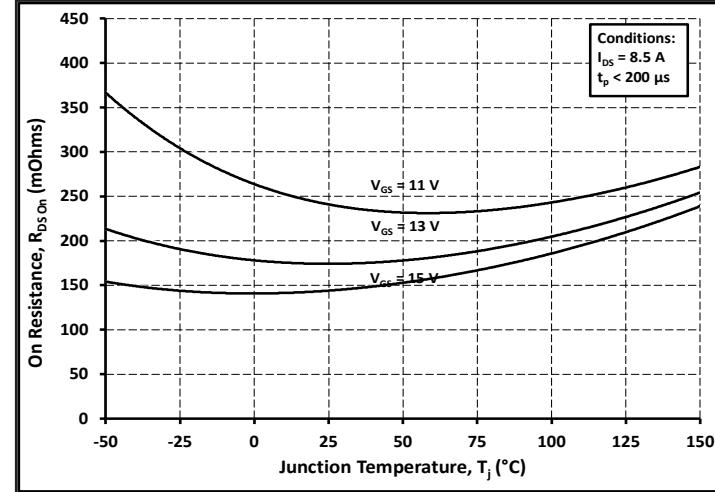
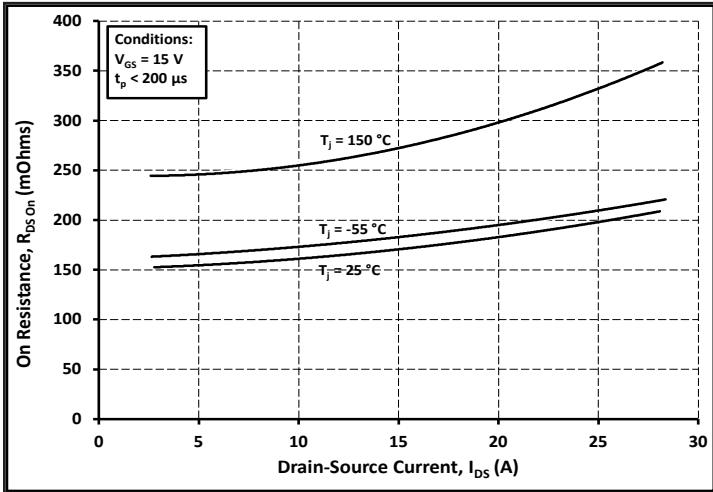


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

Figure 6. On-Resistance vs. Temperature For Various Gate Voltage

Typical Performance

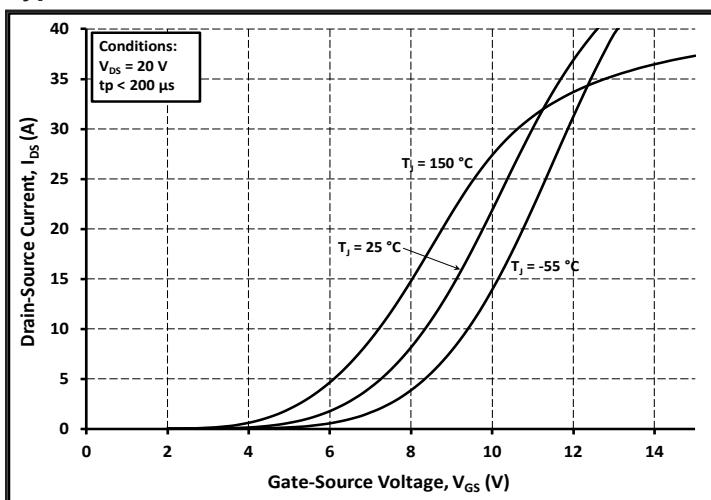


Figure 7. Transfer Characteristic for Various Junction Temperatures

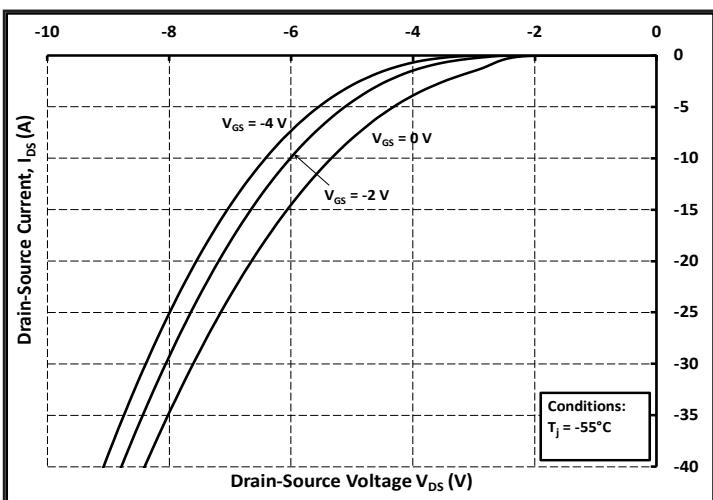


Figure 8. Body Diode Characteristic at -55°C

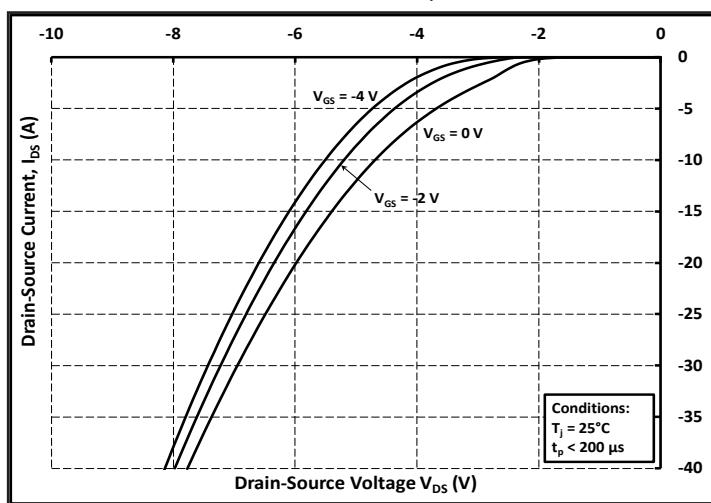


Figure 9. Body Diode Characteristic at 25°C

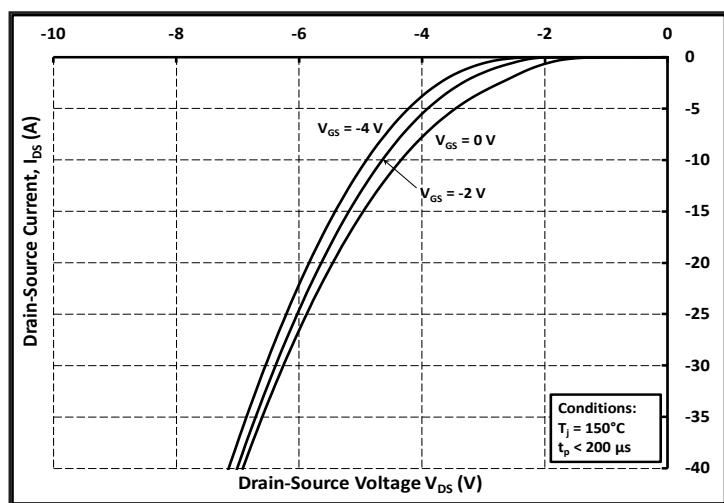


Figure 10. Body Diode Characteristic at 150°C

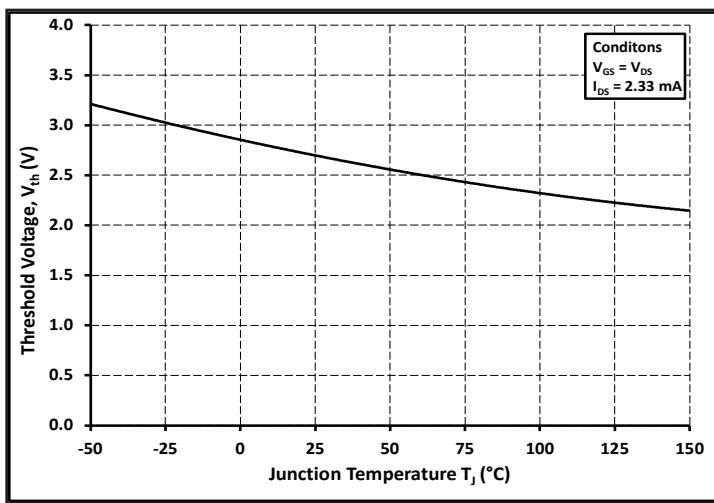


Figure 11. Threshold Voltage vs. Temperature

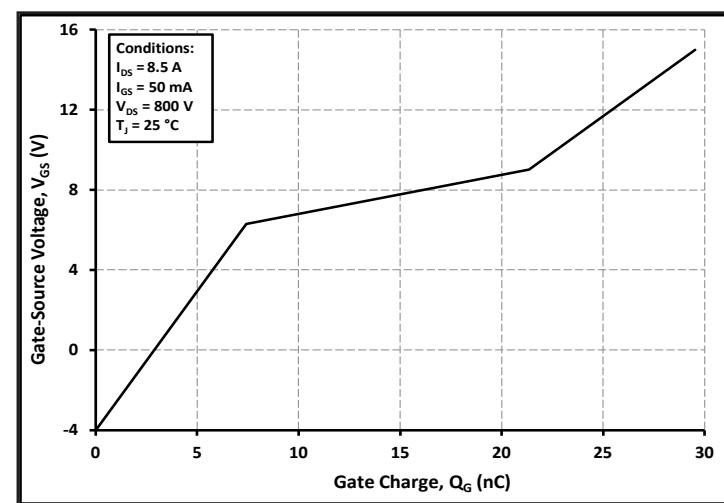


Figure 12. Gate Charge Characteristics

Typical Performance

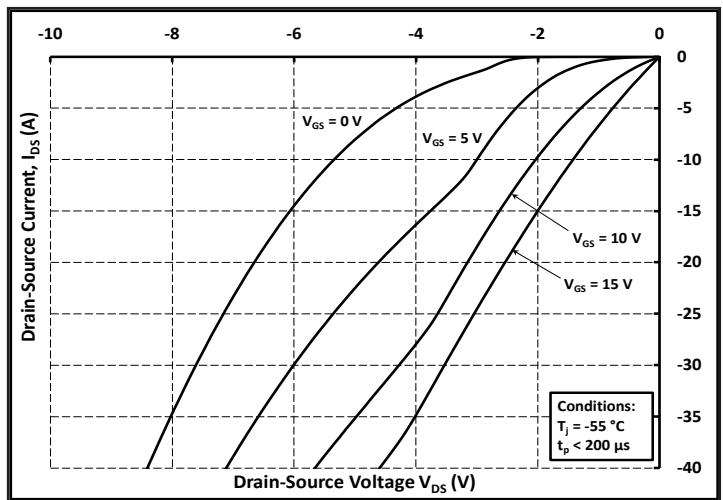


Figure 13. 3rd Quadrant Characteristic at $-55\text{ }^{\circ}\text{C}$

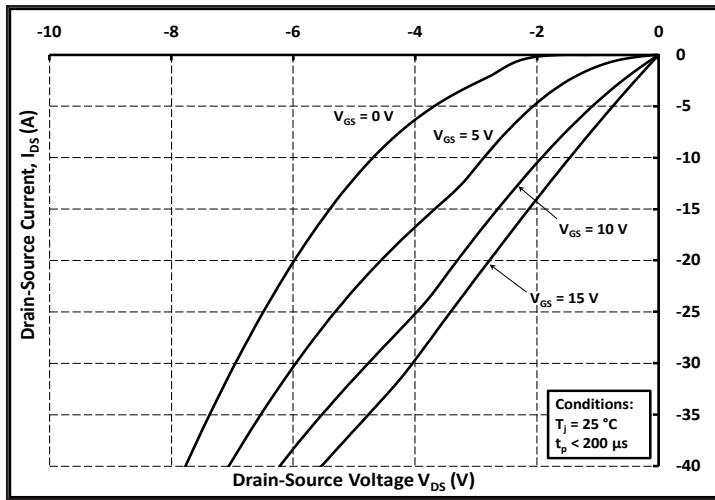


Figure 14. 3rd Quadrant Characteristic at $25\text{ }^{\circ}\text{C}$

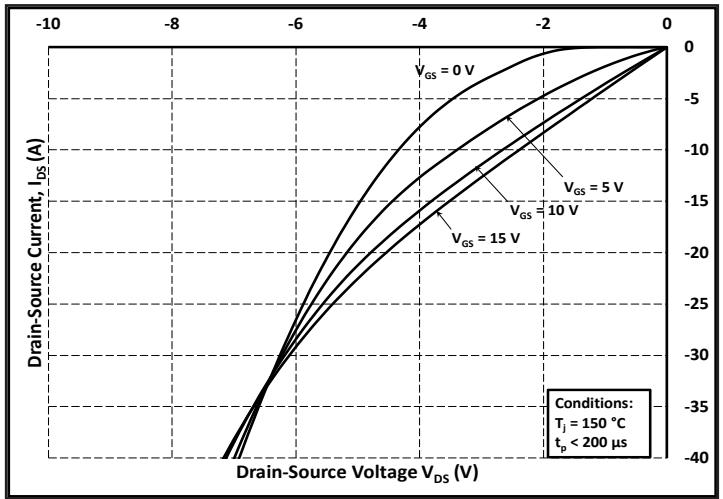


Figure 15. 3rd Quadrant Characteristic at $150\text{ }^{\circ}\text{C}$

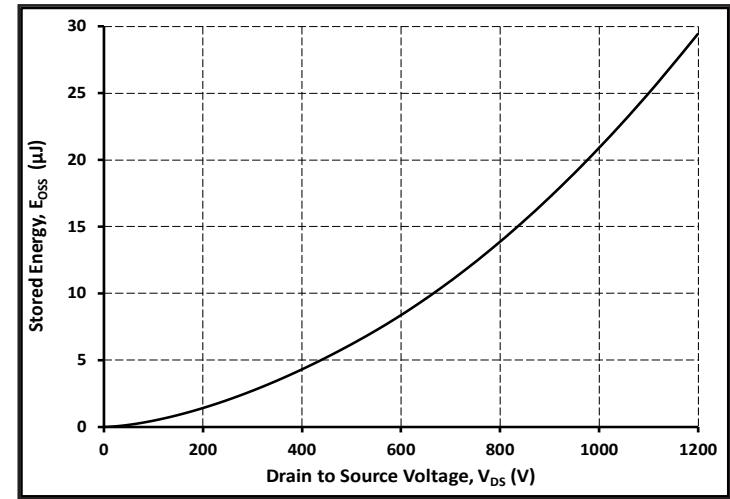


Figure 16. Output Capacitor Stored Energy

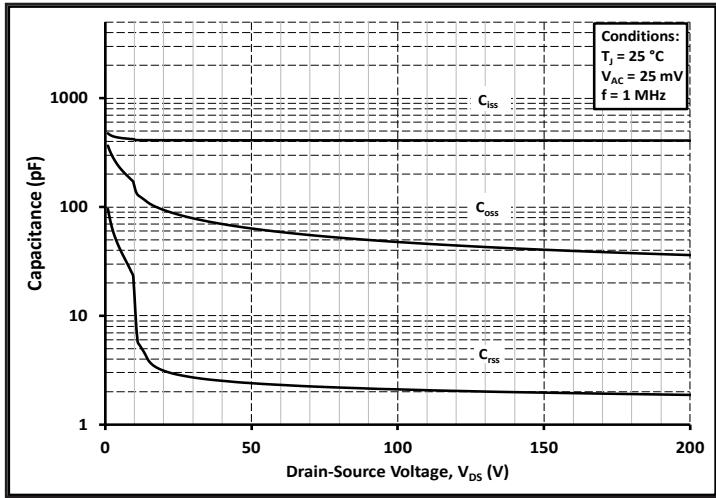


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

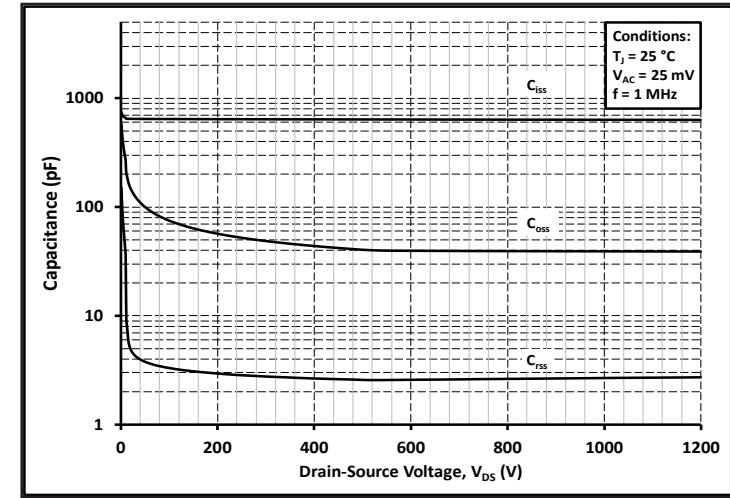


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1200V)

Typical Performance

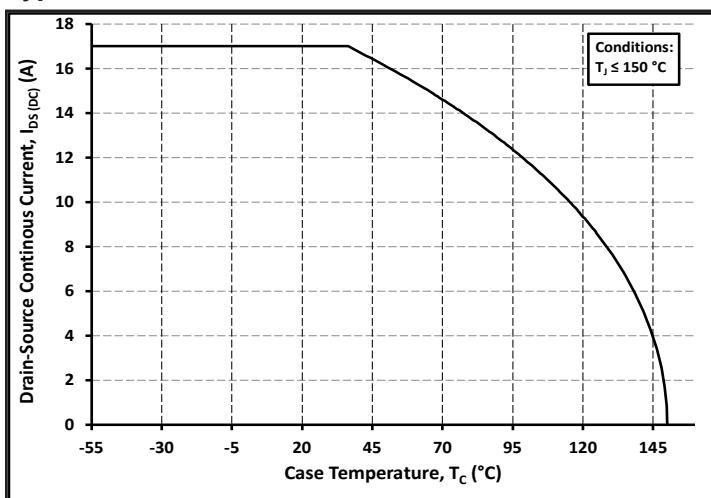


Figure 19. Continuous Drain Current Derating vs.
Case Temperature

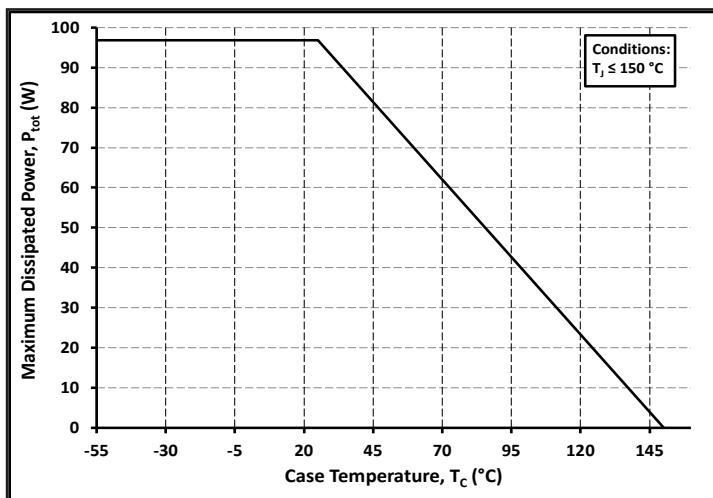


Figure 20. Maximum Power Dissipation Derating vs.
Case Temperature

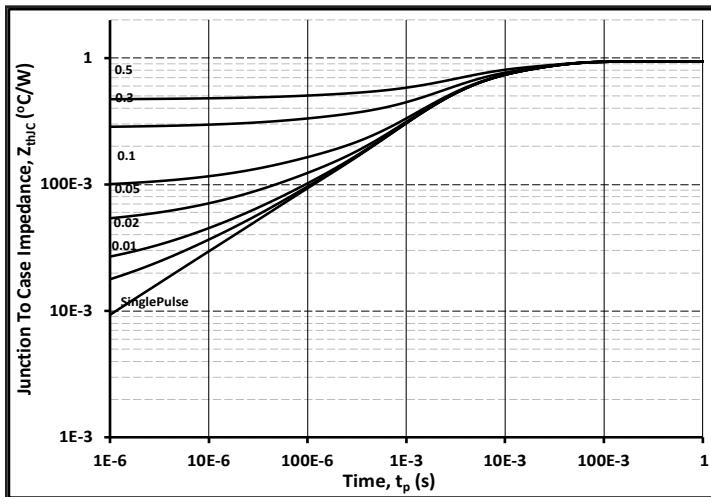


Figure 21. Transient Thermal Impedance
(Junction - Case)

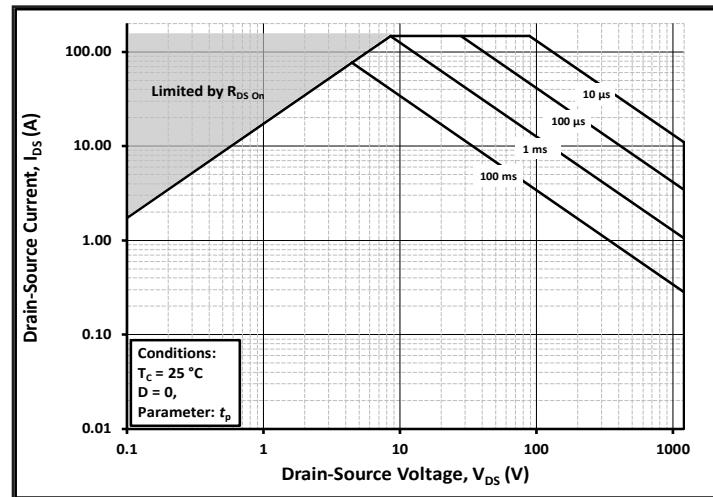


Figure 22. Safe Operating Area

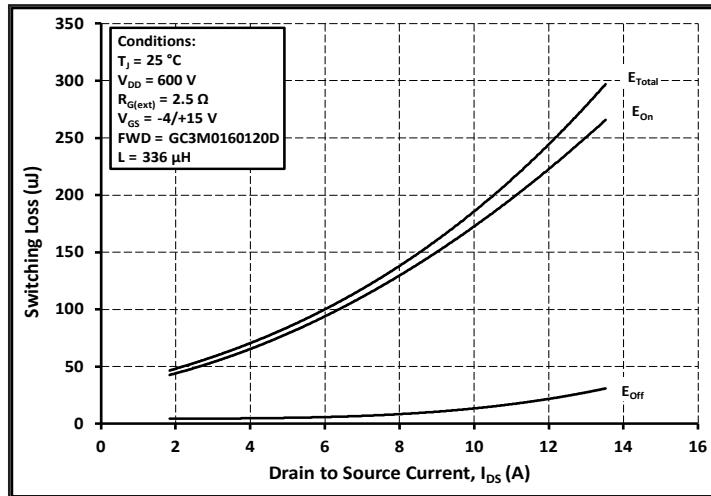


Figure 23. Clamped Inductive Switching Energy vs.
Drain Current ($V_{DD} = 600V$)

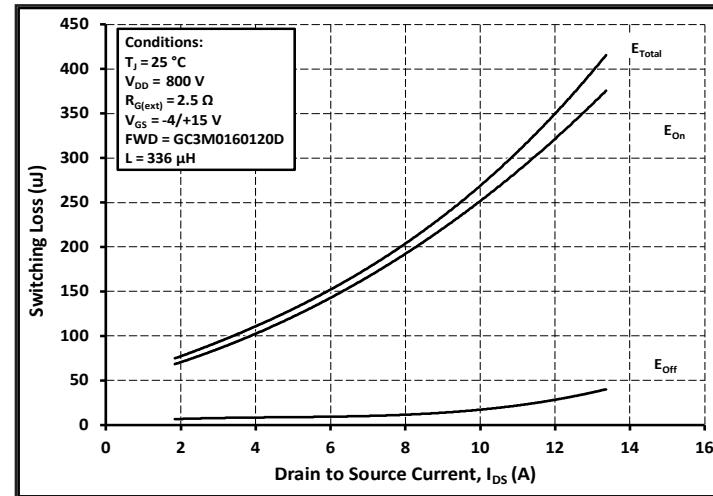


Figure 24. Clamped Inductive Switching Energy vs.
Drain Current ($V_{DD} = 800V$)

Typical Performance

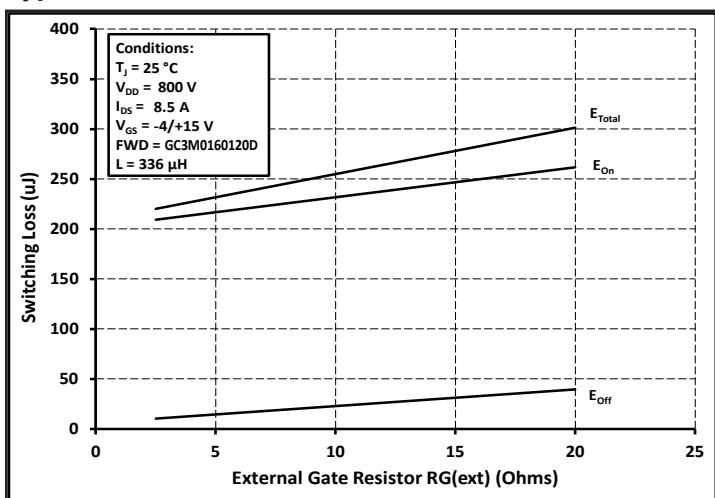


Figure 25. Clamped Inductive Switching Energy vs. $R_{G(\text{ext})}$

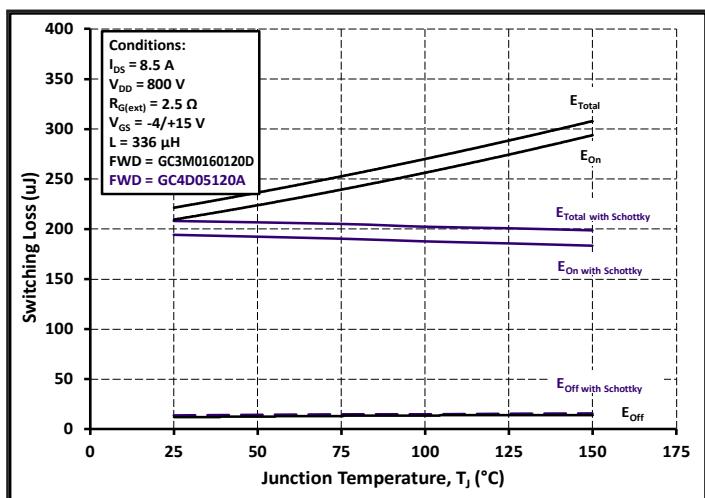


Figure 26. Clamped Inductive Switching Energy vs. Temperature

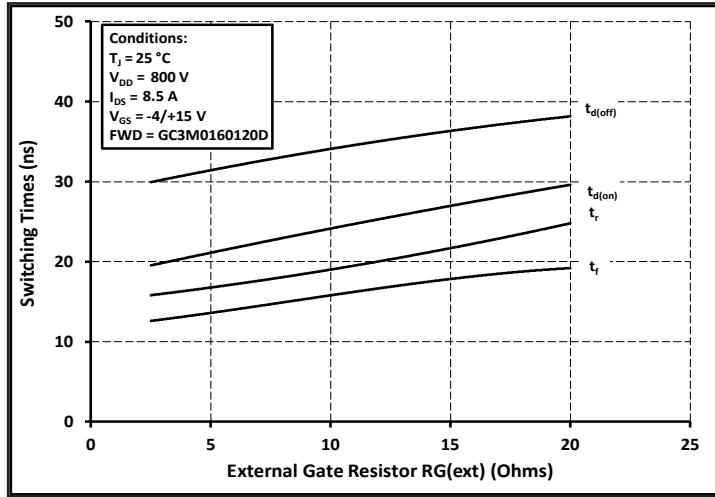


Figure 27. Switching Times vs. $R_{G(\text{ext})}$

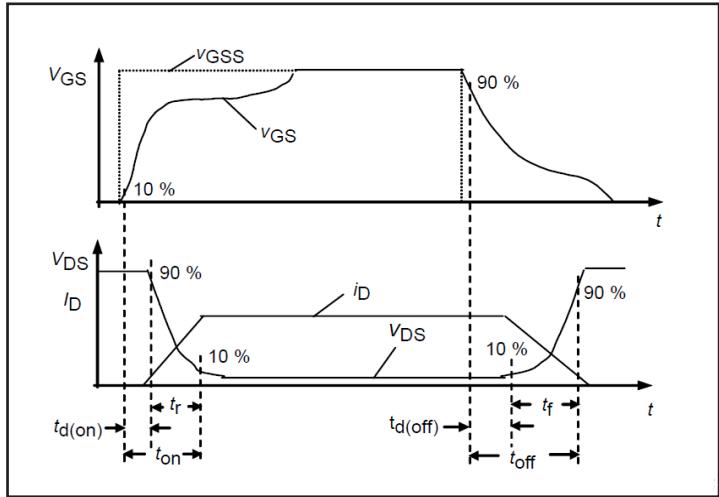


Figure 28. Switching Times Definition

Test Circuit Schematic

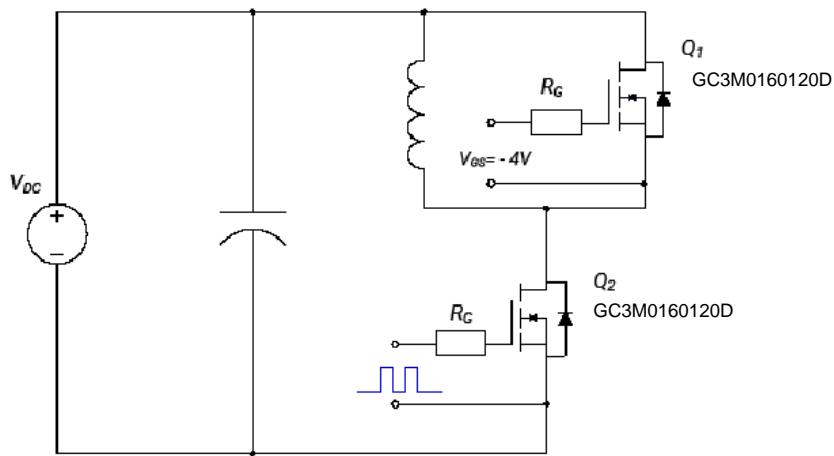
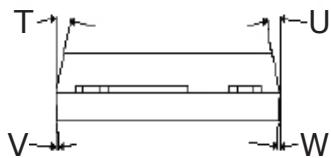
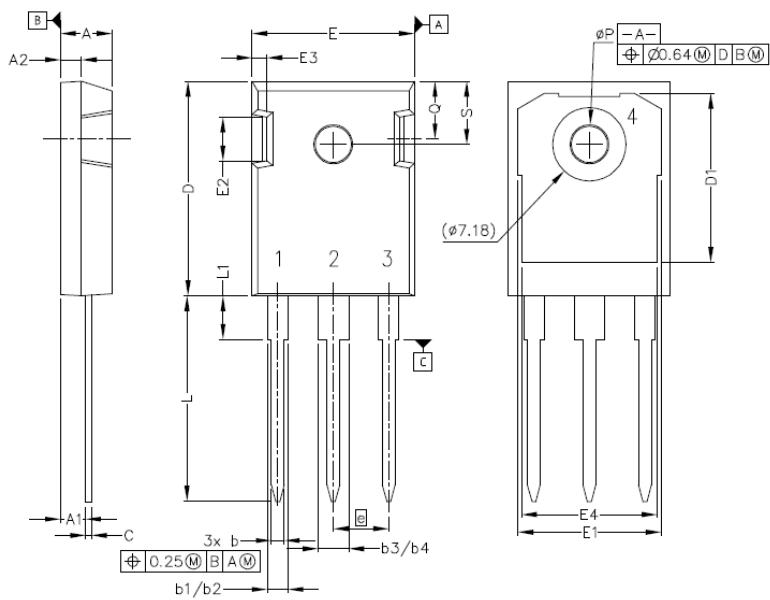


Figure 29. Clamped Inductive Switching Waveform Test Circuit

Note (3): Turn-off and Turn-on switching energy and timing values measured using SiC MOSFET Body Diode as shown above.

Package Dimensions

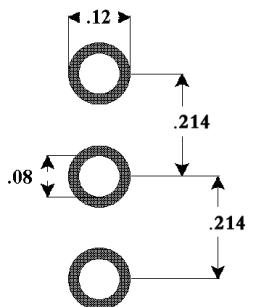
Package TO-247-3



Pinout Information:

- Pin 1 = Gate
 - Pin 2, 4 = Drain
 - Pin 3 = Source

Recommended Solder Pad Layout



TO-247-3